

SSC8226GS8

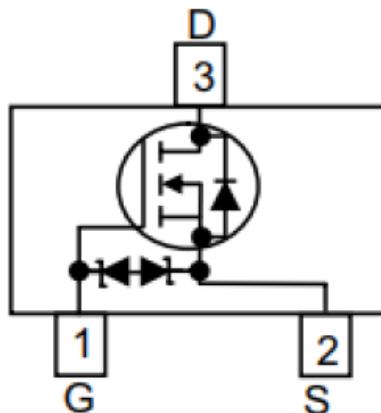
N-Channel Enhancement Mode MOSFET with ESD Protection

➤ Features

VDS	VGS	RDS(on) Typ.	ID	ESD
20V	$\pm 8V$	210mR@4V5	1.2A	2K
		450mR@2V5		

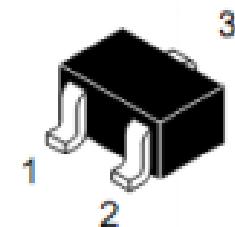
➤ Pin configuration

Top view



➤ Description

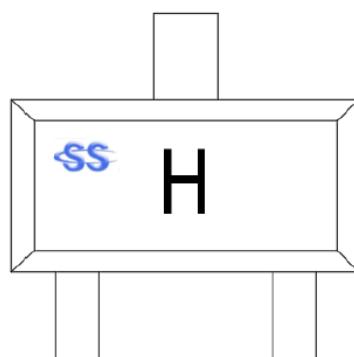
This device is a N-Channel enhancement mode MOSFET which is produced with high cell density and DMOS trench technology. This device particularly suits low voltage applications, especially for battery powered circuits, the tiny and thin outline saves PCB consumption.



➤ Applications

- Replace Digital Transistor
- Battery Operated Systems
- Power Supply Converter Circuits
- Load/Power Switching cell Phones

SOT523



➤ Ordering Information

Device	Package	Shipping
SSC8226GS8	SOT523	3000/Reel

Marking

➤ **Absolute Maximum Ratings($T_A=25^\circ\text{C}$ unless otherwise noted)**

Symbol	Parameter	Ratings	Unit
V_{DSS}	Drain-to-Source Voltage	20	V
V_{GSS}	Gate-to-Source Voltage	± 8	V
I_D	Continuous Drain Current ^a	1.2	A
I_{DM}	Pulsed Drain Current ^b	3.6	A
P_D	Power Dissipation ^c	0.37	W
P_{DSM}	Power Dissipation ^a	0.22	W
T_J	Operation junction temperature	-55 to 150	$^\circ\text{C}$
T_{STG}	Storage temperature range	-55 to 150	$^\circ\text{C}$

➤ **Thermal Resistance Ratings($T_A=25^\circ\text{C}$ unless otherwise noted)**

Symbol	Parameter	Typical	Maximum	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance ^a		567	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Junction-to-Case Thermal Resistance		333	

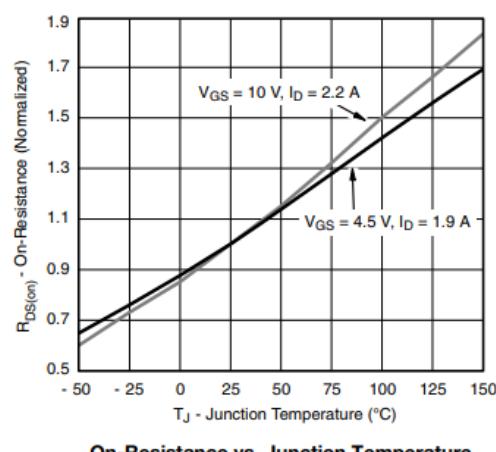
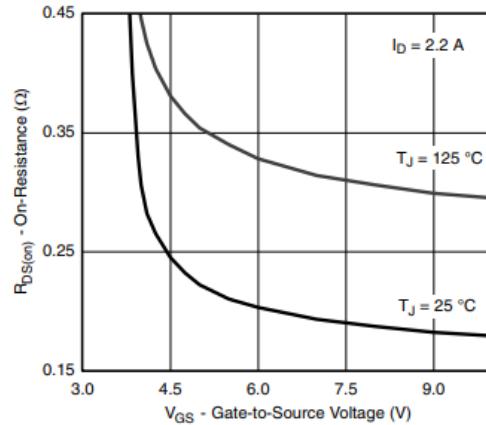
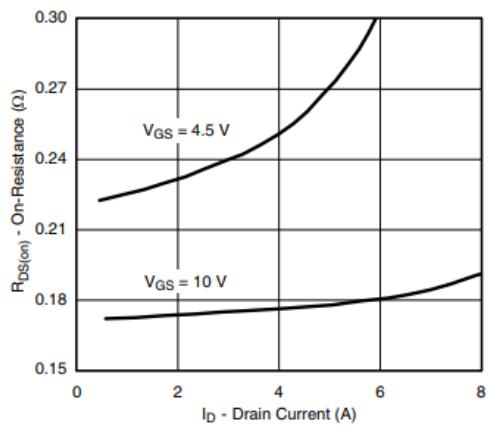
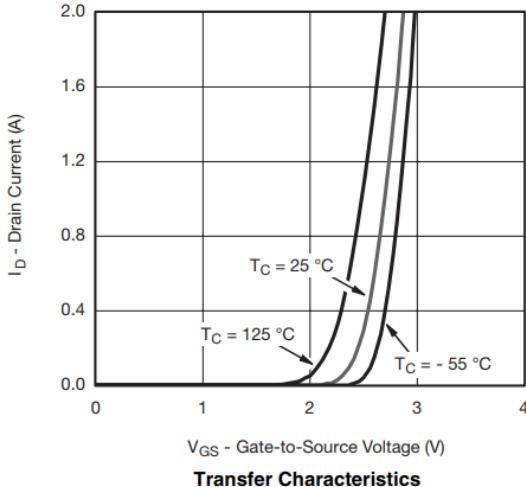
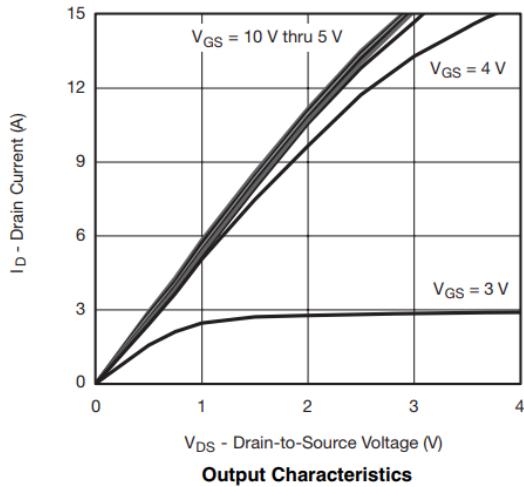
Note:

- a. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2oz.copper,in a still air environment with $T_A=25^\circ\text{C}$.The value in any given application depends on the user specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on $T_J(\text{MAX})=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.

➤ Electronics Characteristics($T_A=25^\circ C$ unless otherwise noted)

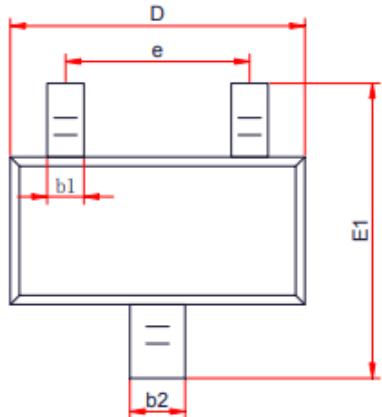
Symbol	Parameter	Test Conditions	Min	Typ.	Max	Unit
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, ID=250\mu A$	20			V
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, ID=250\mu A$	1	1.5	2	V
$R_{DS(on)}$	Drain-Source On-Resistance	$V_{GS}=4.5V, ID=0.5A$		210	480	mR
		$V_{GS}=2.5V, ID=0.5A$		450	700	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=20V, V_{GS}=0V$			1	μA
I_{GSS}	Gate-Source leak current	$V_{GS}=\pm 8V, V_{DS}=0V$			± 10	μA
G_{FS}	Forward Transconductance	$V_{DS}=10V, ID=0.4A$		1		S
V_{SD}	Forward Voltage	$V_{GS}=0V, IS=0.5A$			1.3	V
C_{iss}	Input Capacitance	$V_{DS}=10V, V_{GS}=0V, F=100KHZ$		89		pF
C_{oss}	Output Capacitance			19		
C_{rss}	Reverse Transfer Capacitance			11		
$T_{D(ON)}$	Turn-on delay time	$V_{GS}=4.5V, V_{DD}=10V, RG=6R, ID=0.55A$		21		ns
$T_{D(OFF)}$	Turn-off delay time			680		

➤ **Typical Characteristics**($T_A=25^\circ\text{C}$ unless otherwise noted)

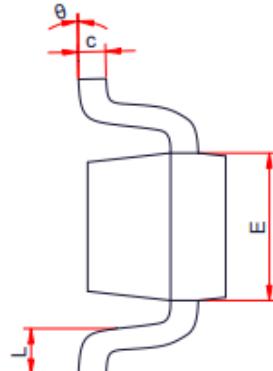


➤ Package Information

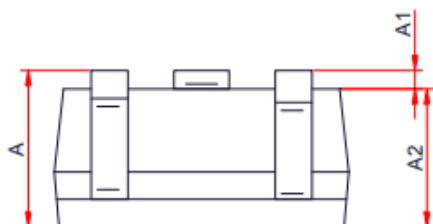
SOT-523



TOP VIEW



SIDE VIEW



SIDE VIEW

Symbol	Dimension in Millimeters	
	Min.	Max.
A	0.700	0.900
A1	0.000	0.100
A2	0.700	0.800
b1	0.150	0.250
b2	0.250	0.350
c	0.100	0.200
D	1.500	1.700
E	0.700	0.900
E1	1.450	1.750
e	0.500 Typ.	
e1	0.900	1.100
L	0.400 Ref.	
L1	0.260	0.460
θ	0°	8°



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